


<b>Search Notes</b> 	<b>Application/Control No.</b> 10810635	<b>Applicant(s)/Patent Under Reexamination</b> CHO ET AL.
	<b>Examiner</b> HELEN SHIBRU	<b>Art Unit</b> 2621

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
modified search	06/30/2008	hs
updated search	11/18/2008	hs

INTERFERENCE SEARCH			
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